

Notice of References Cited

Application/Control No.

10/815,354

Applicant(s)/Patent Under
Reexamination
CHIU ET AL.

Examiner

EDWARD PARK

Art Unit

2624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0126143 a1	09-2002	Bae et al.	345/723
*	B	US-7,091,969 b2	08-2006	Leow et al.	345/420
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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